imall

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BFR705L3RH



NPN Silicon Germanium RF Transistor*

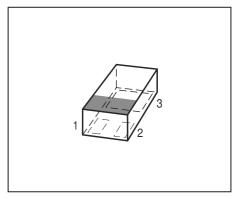
- High gain ultra low noise RF transistor for low current operation
- Ideal for low power consumption LNA design
- Provides outstanding performance for a wide range of wireless applications up to 10 GHz and more
- Outstanding noise figure F = 0.5 dB at 1.8 GHz
 Outstanding noise figure F = 0.8 dB at 6 GHz
- High maximum stable and available gain at only 7m. $G_{ms} = 25 \text{ dB}$ at 1.8 GHz, $G_{ma} = 18 \text{ dB}$ at 6 GHz
- 150 GHz f_T-Silicon Germanium technology
- Extremely small and flat leadless package, height 0.32 mm max.
- Pb-free (RoHS compliant) package¹⁾
- Qualified according AEC Q101
- * Short term description



ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Marking	Pin Configuration			Package
BFR705L3RH	R1	1=B	2=C	3=E	TSLP-3-9

¹Pb-containing package may be available upon special request





Maximum Ratings

Parameter	Symbol	Value	Unit	
Collector-emitter voltage	V _{CEO}		V	
$T_{A} > 0^{\circ}C$		4		
$T_{A} \leq 0^{\circ}C$		3.5		
Collector-emitter voltage	V _{CES}	13		
Collector-base voltage	V _{CBO}	13		
Emitter-base voltage	V _{EBO}	1.2		
Collector current	I _C	10	mA	
Base current	I _B	1		
Total power dissipation ¹⁾ , $T_{S} \le 123 \text{ °C}$	P _{tot}	40	mW	
Junction temperature	Ti	150	°C	
Ambient temperature	T _A	-65 150		
Storage temperature	T _{stg}	-65 150		
Thermal Resistance			•	
Parameter	Symbol	Value	Unit	
Junction - soldering point ²⁾	R _{thJS}	≤ 665	K/W	

Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.]
DC Characteristics	•			•	•
Collector-emitter breakdown voltage	V _{(BR)CEO}	4	4.7	-	V
$I_{\rm C} = 1 {\rm mA}, I_{\rm B} = 0$					
Collector-emitter cutoff current	ICES	-	-	30	μA
$V_{\rm CE} = 13 \text{ V}, V_{\rm BE} = 0$					
Collector-base cutoff current	I _{CBO}	-	-	100	nA
$V_{\rm CB} = 5 \rm V, \ I_{\rm E} = 0$					
Emitter-base cutoff current	I _{EBO}	-	-	1	μA
$V_{\rm EB} = 0.5 \rm V, \ I_{\rm C} = 0$					
DC current gain	h _{FE}	160	250	400	-
$I_{\rm C}$ = 7 mA, $V_{\rm CE}$ = 3 V, pulse measured					

 $^{1}T_{S}$ is measured on the collector lead at the soldering point to the pcb

 2 For calculation of $R_{\rm thJA}$ please refer to Application Note Thermal Resistance



Symbol	Values			Unit
	min.	typ.	max.	
g)			1	1
f _T	-	39	-	GHz
C _{cb}	-	0.04	0.08	pF
C _{ce}	-	0.15	-	
C _{eb}	-	0.18	-	
F				dB
	-	0.5	-	
	-	0.8	-	
G _{ms}	-	25	-	dB
G _{ma}	-	18	-	dB
$ S_{21e} ^2$				dB
	-	21	-	
	-	14	-	
-	g) $f_{\rm T}$ $C_{\rm cb}$ $C_{\rm ce}$ $C_{\rm eb}$ F $G_{\rm ms}$ $G_{\rm ma}$	min. g) min. f_T - C_{cb} - C_{cb} - C_{cb} - C_{cb} - C_{cb} - G_{mb} - G_{ms} - G_{ma} -	min. typ. g) fT 39 f_T - 39 C_{cb} - 0.04 C_{cb} - 0.15 C_{eb} - 0.18 F - 0.5 G_{ms} - 0.5 G_{ms} - 25 G_{ma} - 18 $ S_{21e} ^2$ - 21	min.typ.max.g) f_T -39- f_T -0.040.08 C_{cb} -0.15- C_{ce} -0.15- C_{eb} -0.18- F_{eb} -0.5- G_{ms} -25- G_{ma} -18- $ S_{21e} ^2$ -21-

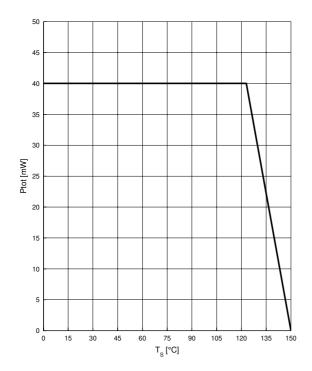
Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified

 ${}^{1}G_{ma} = |S_{21e} / S_{12e}| \ (k - (k^{2} - 1)^{1/2}), \ G_{ms} = |S_{21e} / S_{12e}|$



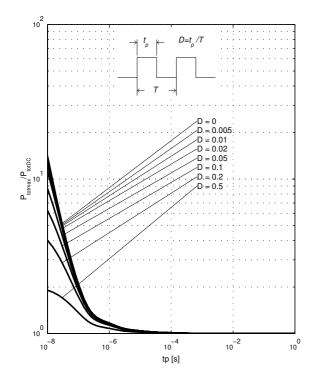
Total power dissipation $P_{tot} = f(T_S)$

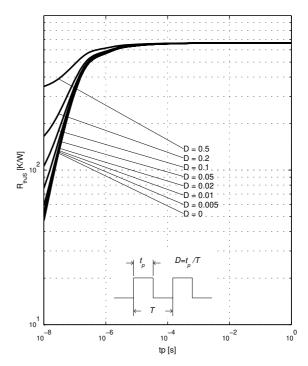
Permissible Puls Load $R_{thJS} = f(t_p)$



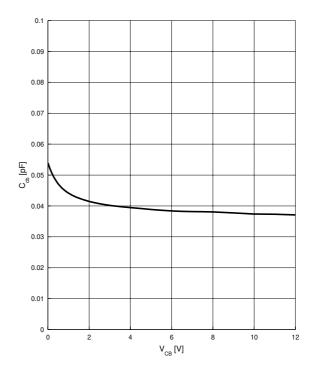
Permissible Pulse Load

 $P_{\text{totmax}}/P_{\text{totDC}} = f(t_{p})$





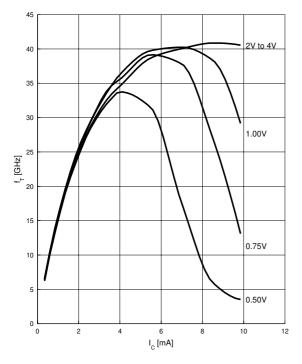
Collector-base capacitance $C_{cb} = f (V_{CB})$ f = 1 MHz





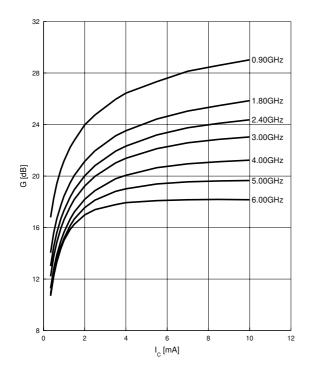
Transition frequency $f_{\rm T} = f(I_{\rm C})$

 V_{CE} = parameter, f = 1 GHz

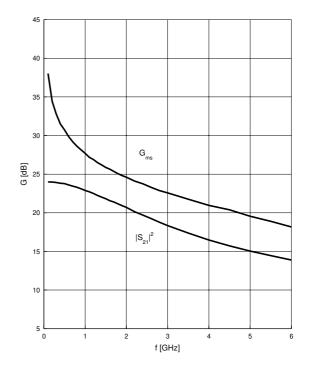


Power gain
$$G_{ma}$$
, $G_{ms} = f(I_C)$
 $V_{CE} = 3 V$

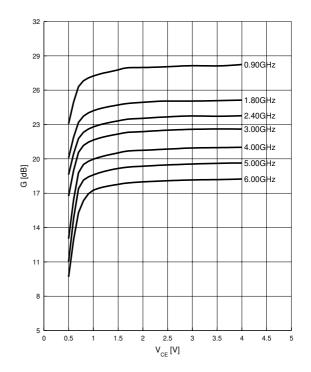
f = parameter



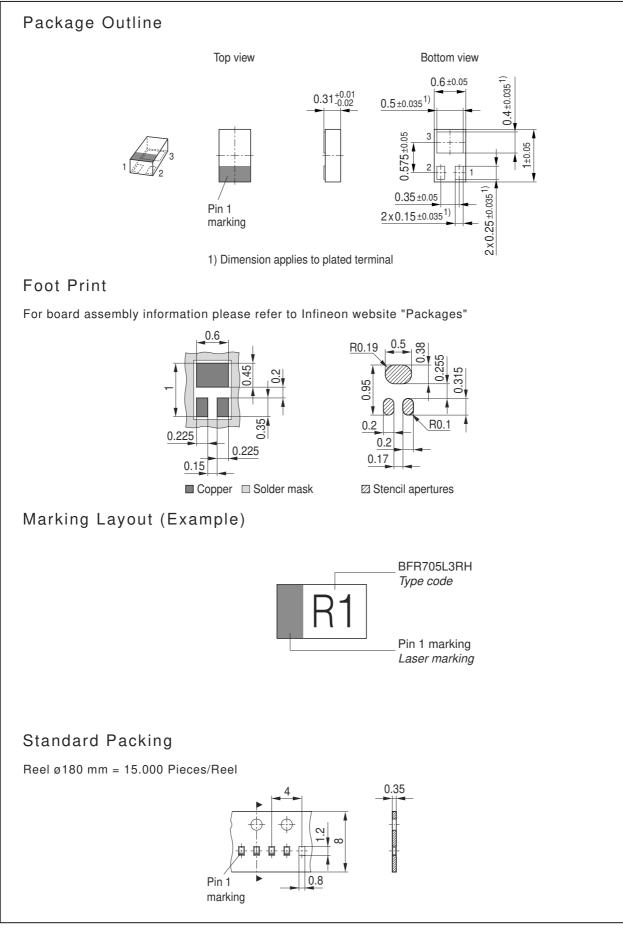
Power gain G_{ma} , $G_{ms} = f(f)$ $V_{CE} = 2 \text{ V}$, $I_C = 7 \text{ mA}$



Power gain G_{ma} , $G_{ms} = f (V_{CE})$ $I_{C} = 7 \text{ mA}$ f = parameter









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